

**Search Notes****Application/Control No.**

10616525

**Applicant(s)/Patent Under Reexamination**

FUNK ET AL.

**Examiner**

Rutten, J. Derek

**Art Unit**

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**SEARCHED****Class****Subclass****Date****Examiner****SEARCH NOTES****Search Notes****Date****Examiner**

717/127-130; 714/34,35 (Updated text search - see search history printout)

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EAST (US-PGPUB; USPAT; EPO; JPO; IBM\_TDB; DERWENT - see search history printout)

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